


<b>Search Notes</b> 	<b>Application/Control No.</b>		<b>Applicant(s)/Patent under Reexamination</b>	
	10/668,586		HSU, JOHN S.	
	<b>Examiner</b>		<b>Art Unit</b>	
	Tamai IE Karl		2834	

SEARCHED			
Class	Subclass	Date	Examiner
310	156.56- 156.61 191, 181		
	190, 43,		
	51, 216	4/14/2005	KIT
UPDATE Search 8/14/05 km			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
h02k001/27.ipc.	11/14/2005	KIT